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Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/827,306	SUN ET AL.	•
Examiner	Art Unit	
Quan-Zhen Wang	2613	

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Class	Subclass	Date	Examiner
398	26,25,33, 38,45,50, 162	2/11/2007	QZW
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INTERFERENCE SEARCHED			
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SEARCH NOT (INCLUDING SEARCH	TES STRATEGY)
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EAST Search	2/11/2007	QZW
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